

# FCP600N60Z / FCPF600N60Z

## N-Channel SuperFET® II MOSFET

600 V, 7.4 A, 600 mΩ

### Features

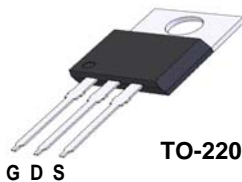
- 650 V @T<sub>J</sub> = 150°C
- Max. R<sub>DS(on)</sub> = 600 mΩ
- Ultra Low Gate Charge (Typ. Q<sub>g</sub> = 20 nC)
- Low Effective Output Capacitance (Typ. C<sub>oss,eff</sub> = 74 pF)
- 100% Avalanche Tested
- ESD Improved Capacity

### Description

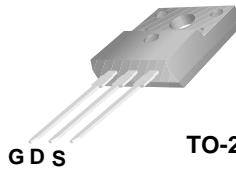
SuperFET®II MOSFET is Fairchild Semiconductor®'s first generation of high voltage super-junction (SJ) MOSFET family that is utilizing charge balance technology for outstanding low on-resistance and lower gate charge performance. This advanced technology is tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. Consequently, SuperFETII MOSFET is suitable for various AC/DC power conversion for system miniaturization and higher efficiency.

### Applications

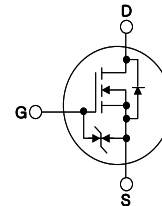
- LCD / LED / PDP TV and Monitor Lighting
- Solar Inverter
- AC-DC Power Supply



TO-220



TO-220F



### MOSFET Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter	FCP600N60Z	FCPF600N60Z	Unit
V <sub>DSS</sub>	Drain to Source Voltage	600		V
V <sub>GSS</sub>	Gate to Source Voltage	- DC	±20	V
		- AC (f > 1 Hz)	±30	V
I <sub>D</sub>	Drain Current	- Continuous (T <sub>C</sub> = 25°C)	7.4	7.4*
		- Continuous (T <sub>C</sub> = 100°C)	4.7	4.7*
I <sub>DM</sub>	Drain Current - Pulsed (Note 1)	22.2	22.2*	A
E <sub>AS</sub>	Single Pulsed Avalanche Energy (Note 2)	135		mJ
I <sub>AR</sub>	Avalanche Current (Note 1)	1.5		A
E <sub>AR</sub>	Repetitive Avalanche Energy (Note 1)	0.89		mJ
dv/dt	Peak Diode Recovery dv/dt (Note 3)	20		V/ns
	MOSFET dv/dt	100		V/ns
P <sub>D</sub>	Power Dissipation (T <sub>C</sub> = 25°C)	89	28	W
		- Derate above 25°C	0.71	0.22
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range	-55 to +150		°C
T <sub>L</sub>	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds	300		°C

\*Drain current limited by maximum junction temperature

### Thermal Characteristics

Symbol	Parameter	FCP600N60Z	FCPF600N60Z	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction to Case	1.4	4.5	°C/W
R <sub>θJA</sub>	Thermal Resistance, Junction to Ambient	62.5	62.5	

## Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FCP600N60Z	FCP600N60Z	TO-220	-	-	50
FCPF600N60Z	FCPF600N60Z	TO-220F	-	-	50

## Electrical Characteristics $T_C = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
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### Off Characteristics

$BV_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 25^\circ\text{C}$	600	-	-	V
		$V_{GS} = 0\text{ V}, I_D = 10\text{ mA}, T_J = 150^\circ\text{C}$	650	-	-	V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = 10\text{ mA}, \text{Referenced to } 25^\circ\text{C}$	-	0.67	-	$\text{V}/^\circ\text{C}$
$BV_{DS}$	Drain-Source Avalanche Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = 7.4\text{ A}$	-	700	-	V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 480\text{ V}, V_{GS} = 0\text{ V}$	-	-	1	$\mu\text{A}$
		$V_{DS} = 480\text{ V}, T_C = 125^\circ\text{C}$	-	-	10	
$I_{GSS}$	Gate to Body Leakage Current	$V_{GS} = \pm 20\text{ V}, V_{DS} = 0\text{ V}$	-	-	$\pm 10$	$\mu\text{A}$

### On Characteristics

$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\text{ }\mu\text{A}$	2.5	-	3.5	V
$R_{DS(on)}$	Static Drain to Source On Resistance	$V_{GS} = 10\text{ V}, I_D = 3.7\text{ A}$	-	0.51	0.6	$\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS} = 20\text{ V}, I_D = 3.7\text{ A}$	-	6.7	-	S

### Dynamic Characteristics

$C_{iss}$	Input Capacitance	$V_{DS} = 25\text{ V}, V_{GS} = 0\text{ V}$ $f = 1\text{ MHz}$	-	840	1120	pF
$C_{oss}$	Output Capacitance		-	630	840	pF
$C_{rss}$	Reverse Transfer Capacitance		-	30	45	pF
$C_{oss}$	Output Capacitance	$V_{DS} = 380\text{ V}, V_{GS} = 0\text{ V}, f = 1.0\text{ MHz}$	-	16.5	-	pF
$C_{oss\text{ eff.}}$	Effective Output Capacitance	$V_{DS} = 0\text{ V to } 480\text{ V}, V_{GS} = 0\text{ V}$	-	74	-	pF
$Q_{g(tot)}$	Total Gate Charge at 10V	$V_{DS} = 380\text{ V}, I_D = 3.7\text{ A}$ $V_{GS} = 10\text{ V}$	-	20	26	nC
$Q_{gs}$	Gate to Source Gate Charge		-	3.4	-	nC
$Q_{gd}$	Gate to Drain "Miller" Charge		(Note 4)	-	7.5	-
ESR	Equivalent Series Resistance	Drain open	-	2.89	-	$\Omega$

### Switching Characteristics

$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 380\text{ V}, I_D = 3.7\text{ A}$ $V_{GS} = 10\text{ V}, R_G = 4.7\text{ }\Omega$	-	13	36	ns
$t_r$	Turn-On Rise Time		-	7	24	ns
$t_{d(off)}$	Turn-Off Delay Time		-	39	88	ns
$t_f$	Turn-Off Fall Time		(Note 4)	-	9	28

### Drain-Source Diode Characteristics

$I_S$	Maximum Continuous Drain to Source Diode Forward Current	-	-	7.4	A	
$I_{SM}$	Maximum Pulsed Drain to Source Diode Forward Current	-	-	22.2	A	
$V_{SD}$	Drain to Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_{SD} = 3.7\text{ A}$	-	-	1.2	V
$t_{rr}$	Reverse Recovery Time	$V_{GS} = 0\text{ V}, I_{SD} = 3.7\text{ A}$	-	200	-	ns
$Q_{rr}$	Reverse Recovery Charge	$di_F/dt = 100\text{ A}/\mu\text{s}$	-	2.3	-	$\mu\text{C}$

#### Notes:

1. Repetitive Rating: Pulse width limited by maximum junction temperature
2.  $I_{AS} = 1.5\text{ A}, V_{DD} = 50\text{ V}, R_G = 25\text{ }\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3.  $I_{SD} \leq 3.7\text{ A}, di/dt \leq 200\text{ A}/\mu\text{s}, V_{DD} \leq BV_{DSS}$ , Starting  $T_J = 25^\circ\text{C}$
4. Essentially Independent of Operating Temperature Typical Characteristics

## Typical Performance Characteristics

Figure 1. On-Region Characteristics

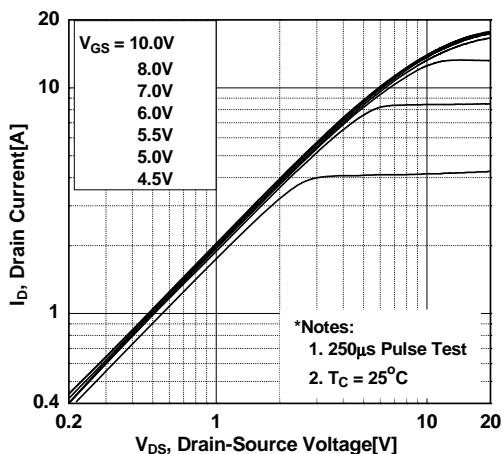


Figure 2. Transfer Characteristics

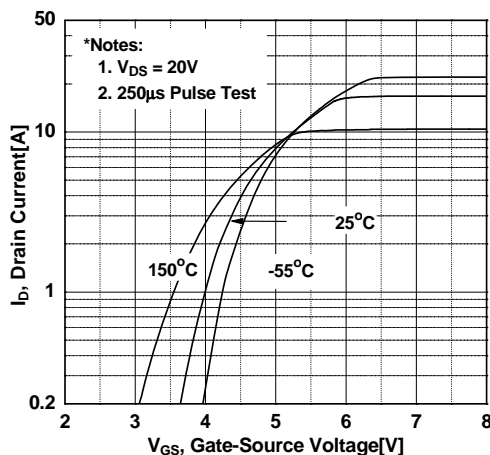


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

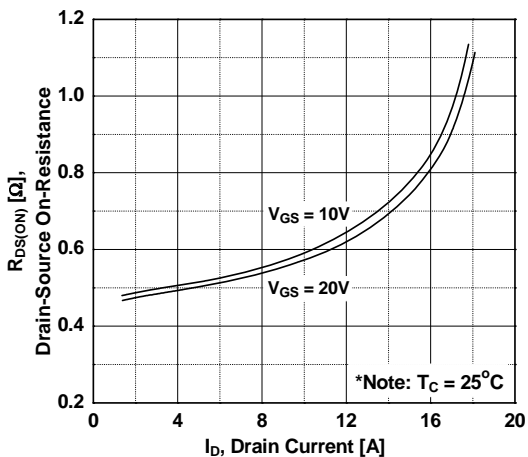


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

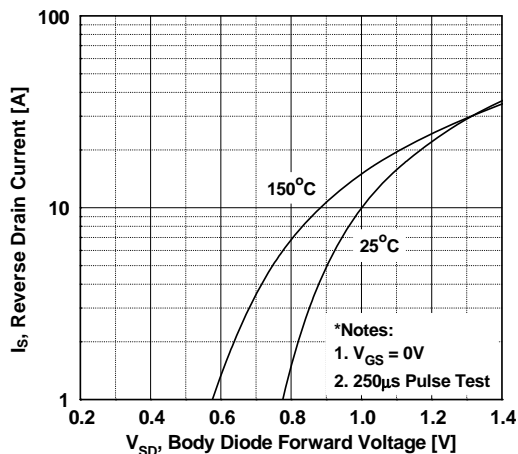


Figure 5. Capacitance Characteristics

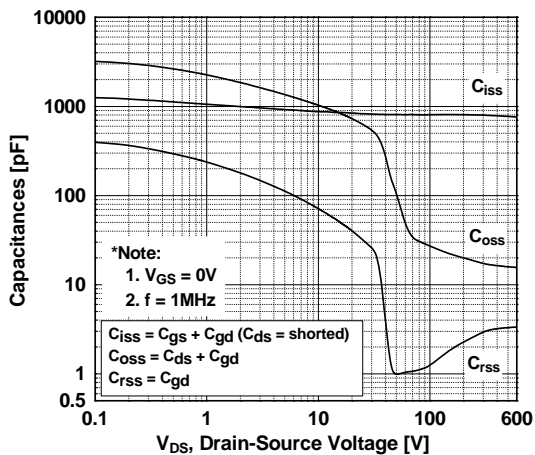
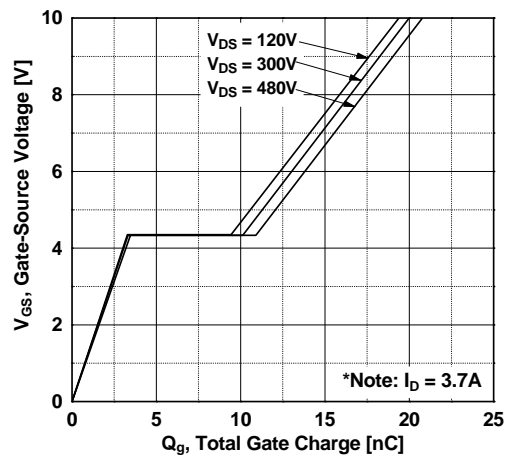
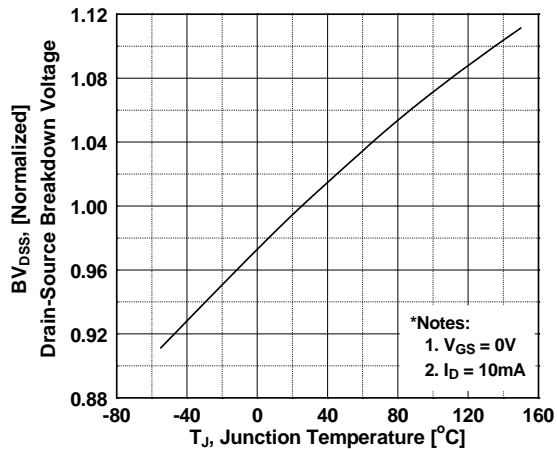


Figure 6. Gate Charge Characteristics

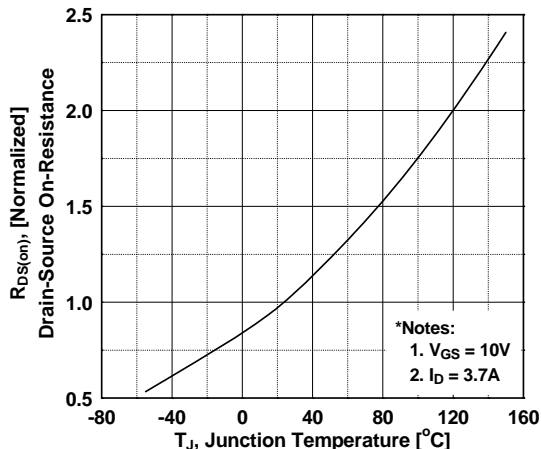


**Typical Performance Characteristics** (Continued)

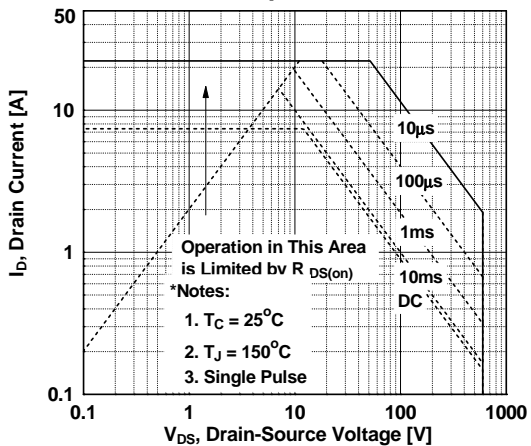
**Figure 7. Breakdown Voltage Variation vs. Temperature**



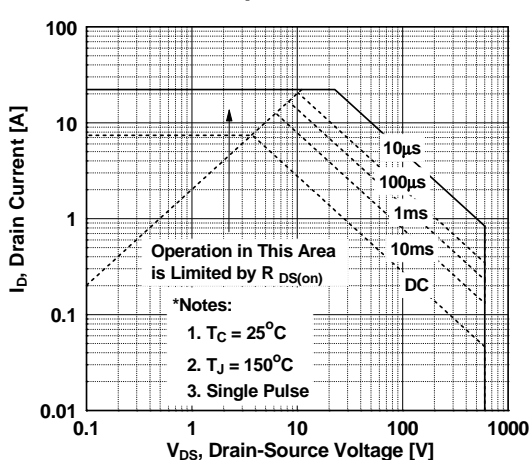
**Figure 8. On-Resistance Variation vs. Temperature**



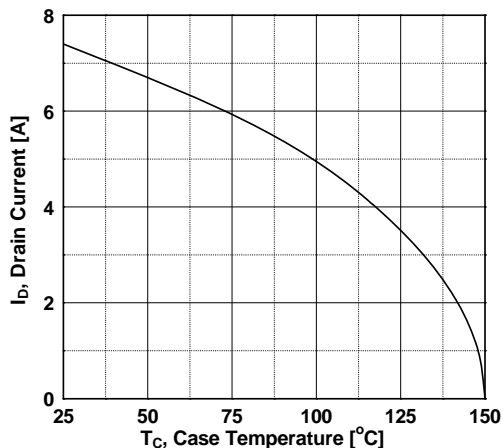
**Figure 9. Maximum Safe Operating Area vs. Case Temperature - FCP600N60Z**



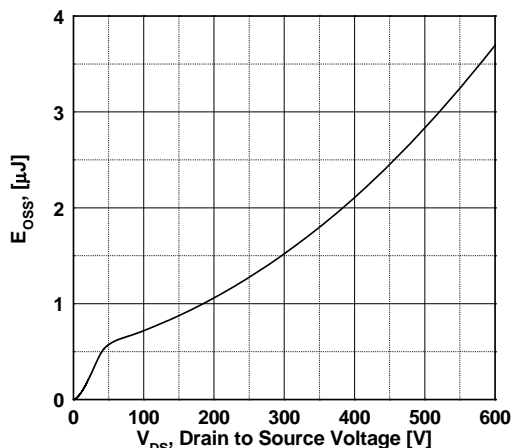
**Figure 10. Maximum Safe Operating Area vs. Case Temperature - FCP600N60Z**



**Figure 11. Maximum Drain Current**



**Figure 12. E\_oss vs. Drain to Source Voltage Switching Capability**



Typical Performance Characteristics (Continued)

Figure 13. Transient Thermal Response Curve - FCP600N60Z

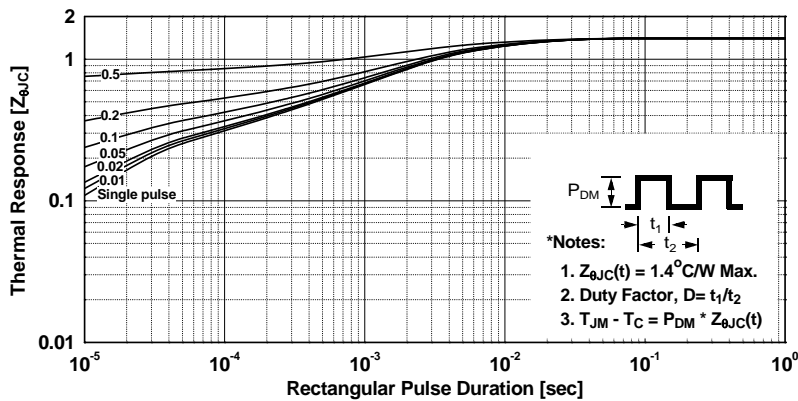
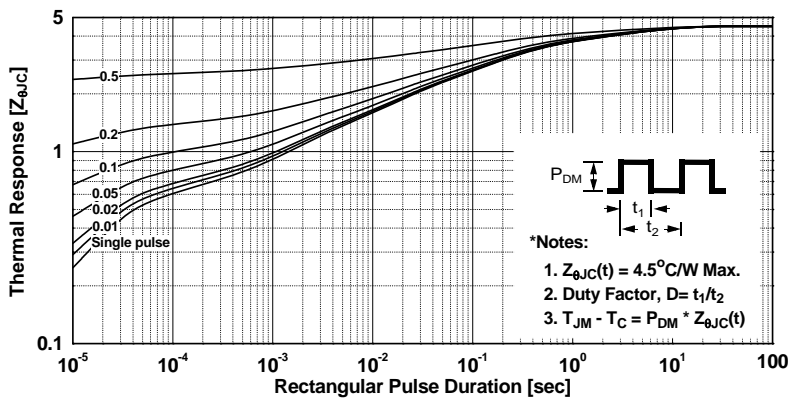
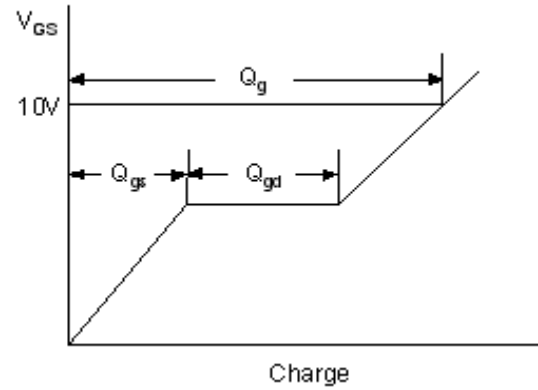
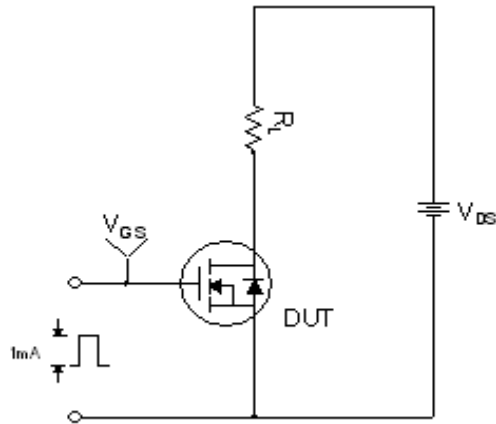


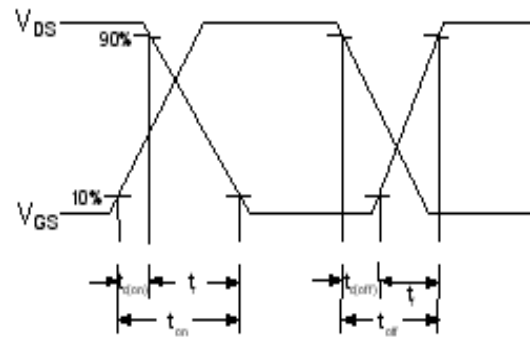
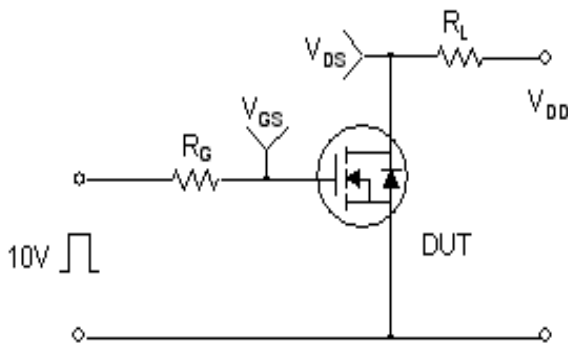
Figure 14. Transient Thermal Response Curve - FCPF600N60Z



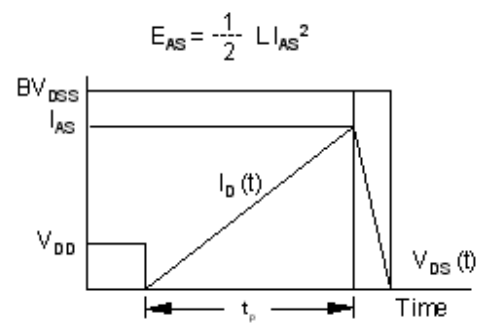
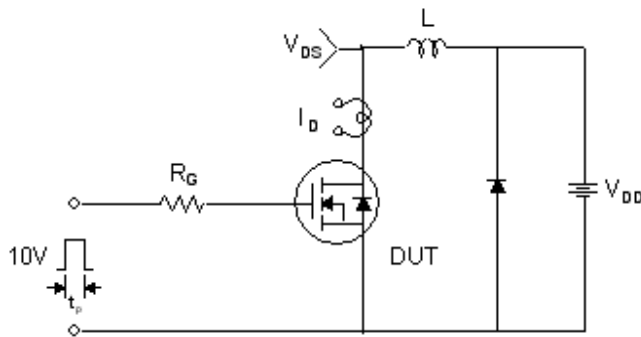
**Gate Charge Test Circuit & Waveform**



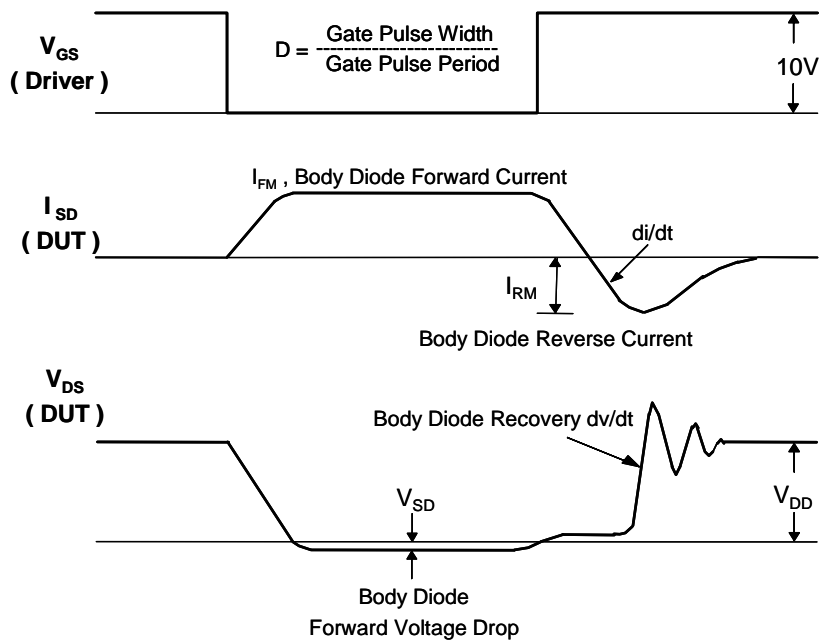
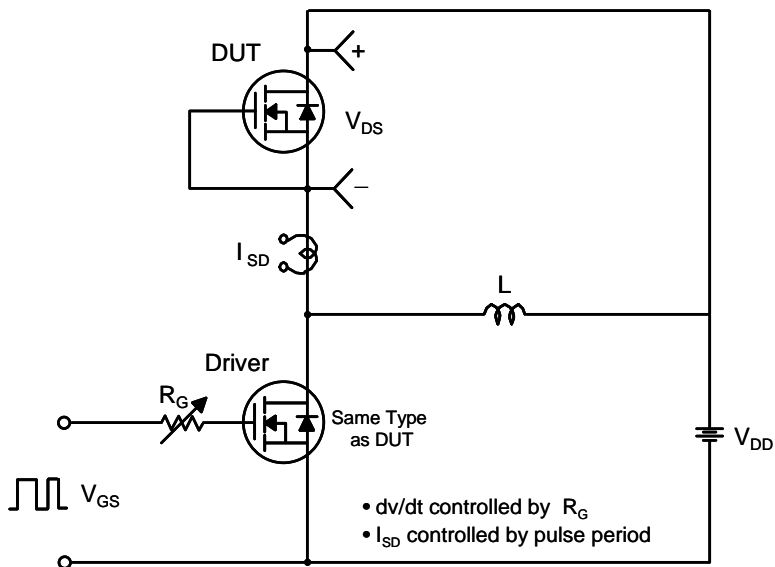
**Resistive Switching Test Circuit & Waveforms**



**Unclamped Inductive Switching Test Circuit & Waveforms**

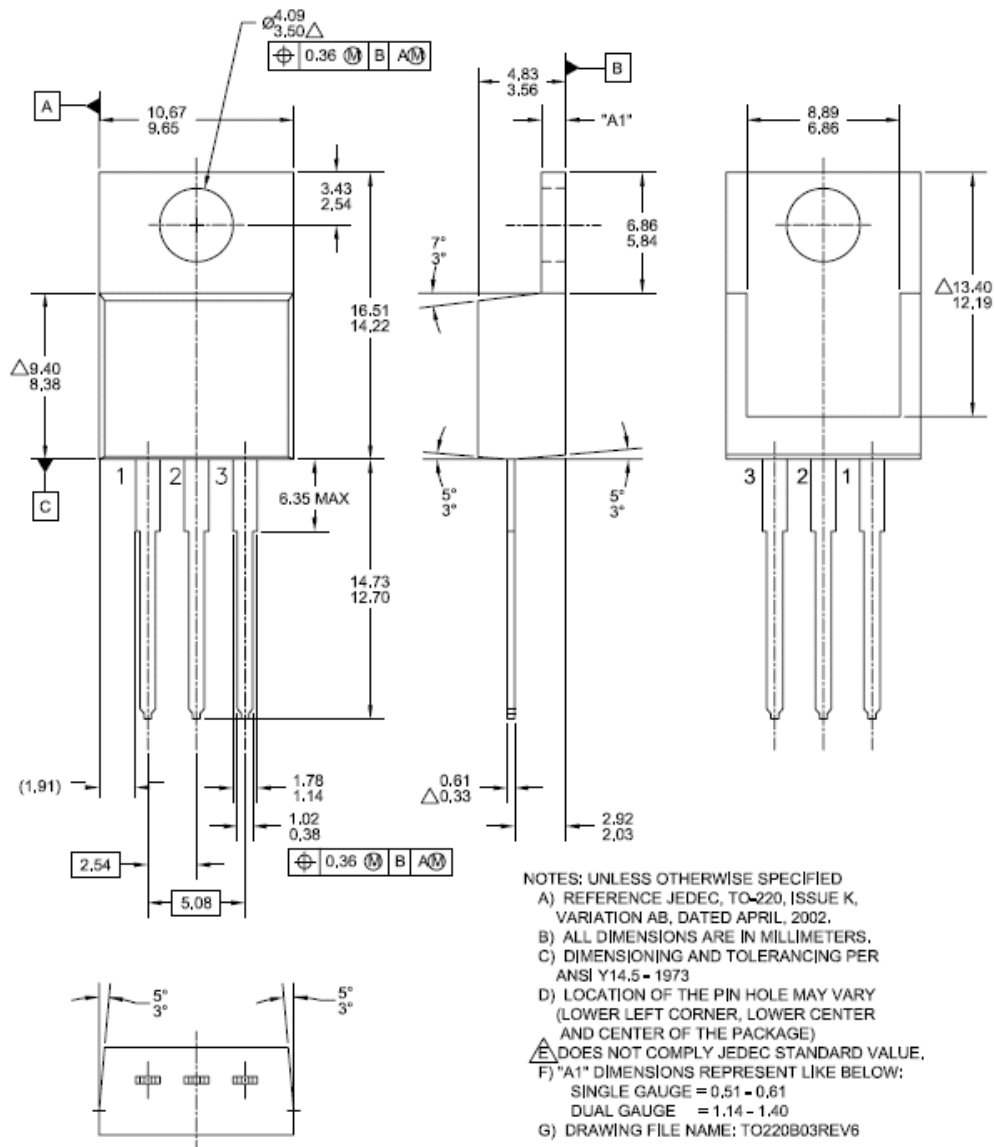


Peak Diode Recovery dv/dt Test Circuit & Waveforms



Mechanical Dimensions

TO-220AB














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